Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,785	MITAMURA ET AL.	
Examiner	Art Unit	
Patrick J. Lee	2878	

			 		
SEARCHED					
Class	Subclass	Date	Examiner		
250	231.13, 231.14, 231.17, 237R	12/12/2005	PL		
250	237G	12/12/2005	PL		
341	13-14	12/12/2005	PL		
33	1PT	12/12/2005	PL		
356	614-616	12/12/2005	PL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted S. Allen	6/9/2005	PL		
East (see attached) - USPAT, USPG- PUB, EPO, JPO, DERWENT	6/10/2005	PL		
East (see attached) - USPAT, USPG- PUB, EPO, JPO, DERWENT	6/13/2005	PL		
East (see attached) - USPAT, USPG- PUB, EPO, JPO, DERWENT	6/14/2005	PL		
East (see attached) - USPAT, USPG- PUB, EPO, JPO, DERWENT	12/12/2005	PL		